TSEK03: Radio Frequency Integrated Circuits (RFIC)

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Background: Overview

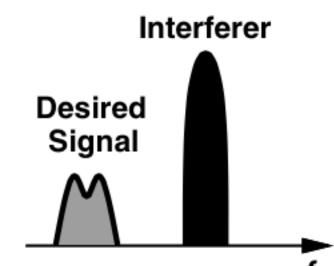
- Razavi:
 - -Chapter 2.2 Effects of nonlinearity (mostly repetition from TSEK02)
 -Chapter 2.5 Matching
 -Chapter 2.6 Scattering parameters
- Lee:

-Chapter 7 Smith chart and s-parameters



2.2 Linearity

- When strong signals are received, the LNA should remain linear.
- Typically, weak signals are received in the presence of a strong interference. Linearity is important to suppress intermodulation distortion.



• For a nonlinear device:

 $i(V_{DC} + v) \approx a_0 + a_1 v + a_2 v^2 + a_3 v^3 + \dots$



Harmonic Distortion

• Consider a nonlinear system

x(t)
$$- y(t) = \alpha_1 V_{in} + \alpha_2 V_{in}^2 + \alpha_3 V_{in}^3 + ...$$

Let us apply a single-tone (Acos ωt) to the input and calculate the output:

$$y(t) = \alpha_1 A \cos \omega t + \alpha_2 A^2 \cos^2 \omega t + \alpha_3 A^3 \cos^3 \omega t$$

$$= \alpha_1 A \cos \omega t + \frac{\alpha_2 A^2}{2} (1 + \cos 2\omega t) + \frac{\alpha_3 A^3}{4} (3 \cos \omega t + \cos 3\omega t)$$

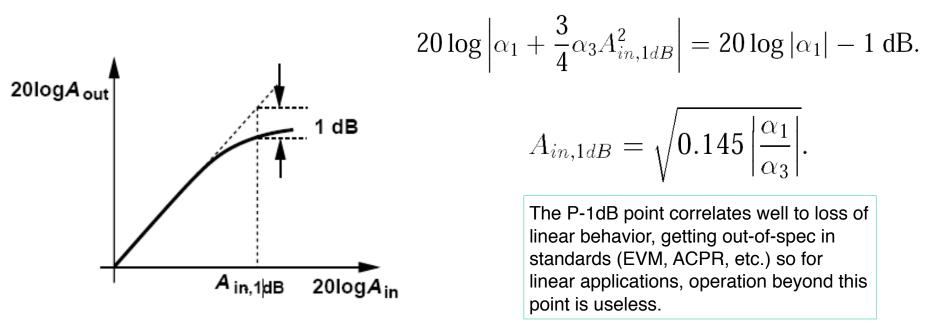
$$= \frac{\alpha_2 A^2}{2} + \left(\alpha_1 A + \frac{3\alpha_3 A^3}{4}\right) \cos \omega t + \frac{\alpha_2 A^2}{2} \cos 2\omega t + \frac{\alpha_3 A^3}{4} \cos 3\omega t.$$

DC Fundamental Second Harmonic Third Harmonic



1-dB Compression Point

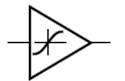
If sign of a₁ and a₃ are opposite then the point in which the output falls below its ideal value by 1 dB is called 1-dB compression point or P-1dB:





Intermodulation

• If a two-tone signal is applied to a non-linear device: $\begin{aligned} v &= A[cos(\omega_1 t) + cos(\omega_2 t)] \\ i(V_{DC} + v) \approx c_0 + c_1 v + c_2 v^2 + c_3 v^3 + \dots \end{aligned}$



- By combining these equations we get several tones:
 - DC and fundamental tones

$$(c_0 + c_2 A^2) + (c_1 A + \frac{9}{4} c_3 A^3) [\cos(\omega_1 t) + \cos(\omega_2 t)]$$

- Second and third harmonic terms

$$\left(\frac{c_2 A^2}{2}\right)\left[\cos(2\omega_1 t) + \cos(2\omega_2 t)\right] + \left(\frac{c_3 A^3}{4}\right)\left[\cos(3\omega_1 t) + \cos(3\omega_2 t)\right]$$

- Second order intermodulation (IM) products

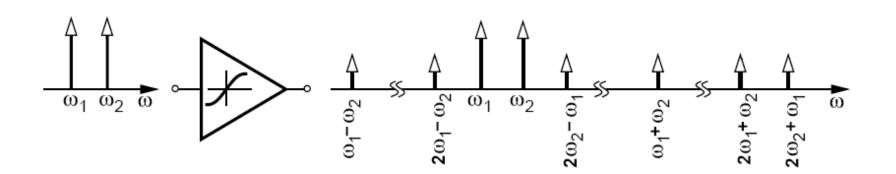
$$\left(\frac{c_2 A^2}{2}\right)\left[\cos(\omega_1 + \omega_2)t + \cos(\omega_1 - \omega_2)t\right]$$

- Third order IM products

$$\left(\frac{3c_3A^3}{4}\right)\left[\cos(2\omega_1+\omega_2)t + \cos(2\omega_1-\omega_2)t + \cos(\omega_1-2\omega_2)t + \cos(\omega_1+2\omega_2)t\right]$$



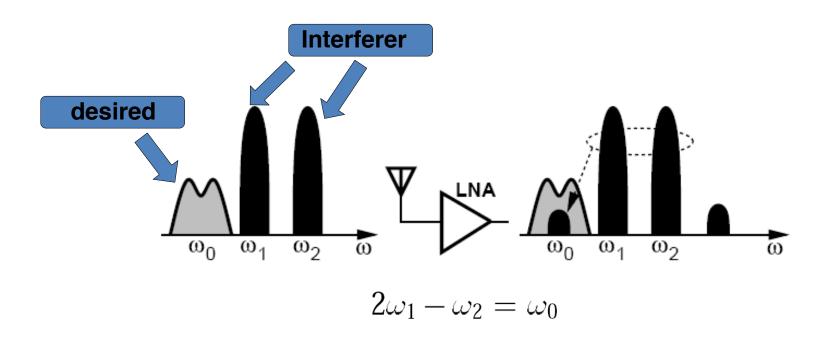
Intermodulation





Intermodulation

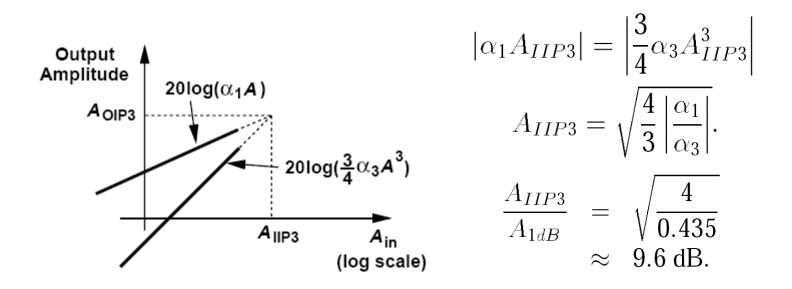
• Typically, weak signals are received in the presence of a strong interference. This might cause intermodulation distortion.





Third-Order Intercept Point (IP3)

 Input-referred third-order intercept point (IIP3) is calculated by setting the IM3 products equal to the amplitude of the fundamental tone (A₁=A₂=A):





IP3: measurement

- Circuits are non-linear at high power levels
- Measured at low power levels (check the slopes!), extrapolate!

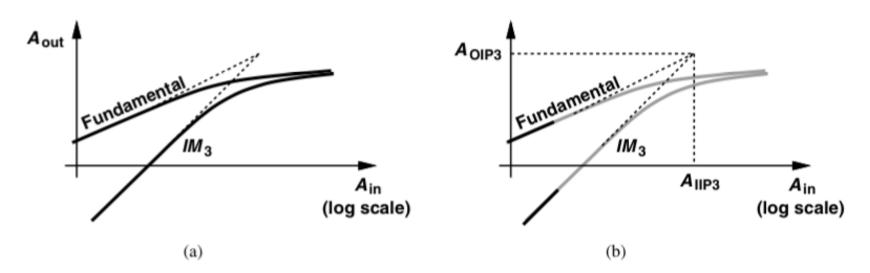
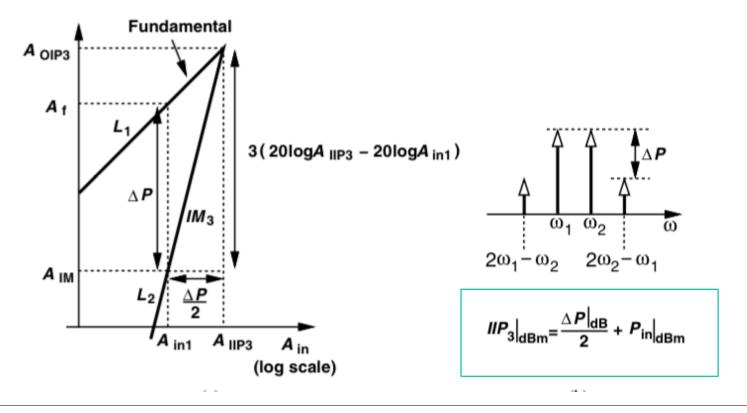


Figure 2.21 (a) Actual behavior of nonlinear circuits, (b) definition of IP₃ based on extrapolation.



IP3: measurement

• Shortcut technique if slopes are OK.

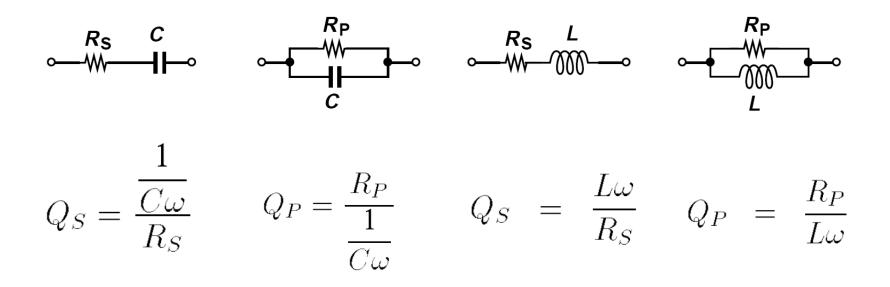




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2.5 Passive impedance transformation

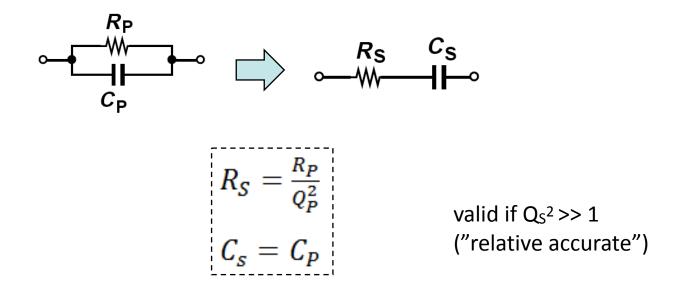
- a.k.a. "matching networks"
- Quality Factor, Q, indicates how close to ideal an energystoring device is.





Parallel-to-series conversion

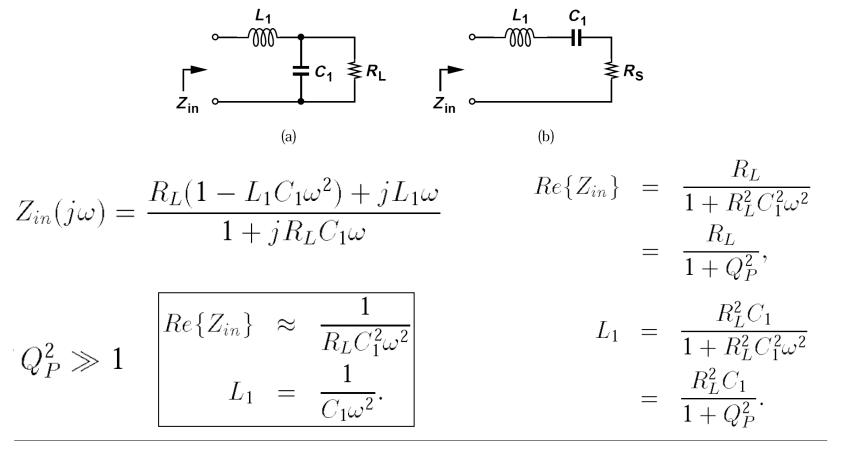
- Series-to-Parallel Conversion: will retain the value of the capacitor but raises the resistance by a factor of Q_s^2
- Parallel-to-Series Conversion: will reduce the resistance by a factor of Q_P²





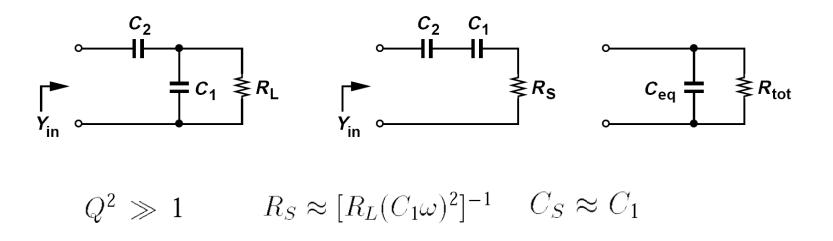
Basic matching networks

• Load resistance transformed to a lower value ($Z_{in} < R_L$):





Transfer a resistance to a higher value



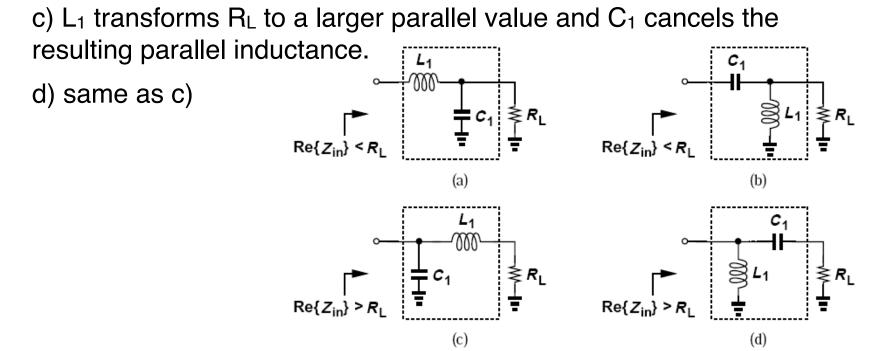
Note that any imaginary component (often capacitance) must first be cancelled by an inductor at the input.



L sections

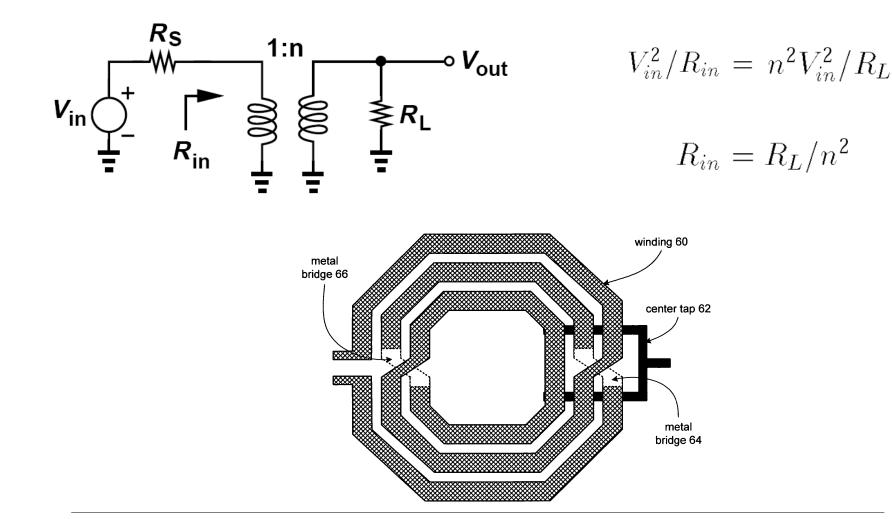
a) C_1 transforms R_L to a smaller series value and L_1 cancels C_1 .

b) L_1 transforms R_L to a smaller series value while C_1 resonates with L_1 .



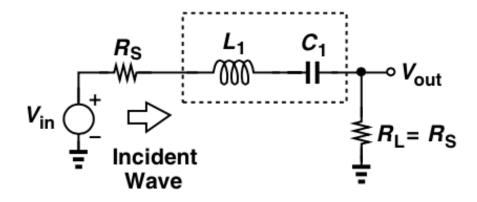


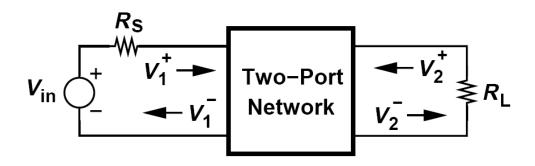
Impedance matching by transformers





2.6 Scattering (S-) parameters

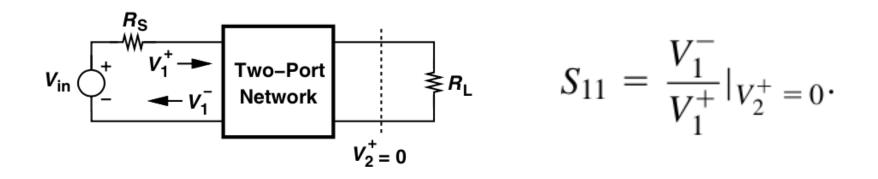






S-parameters

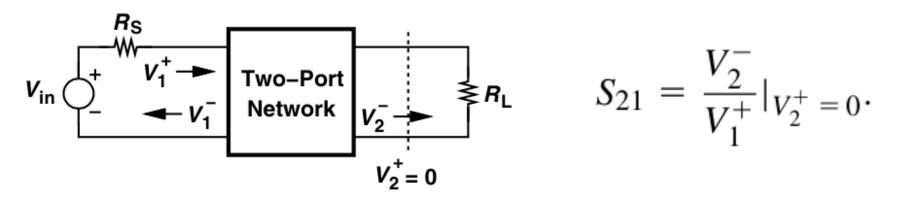
S₁₁ is the ratio of the reflected and incident waves at the input port when the reflection from R_L (i.e., V₂⁺) is zero.
 Represents the input matching.





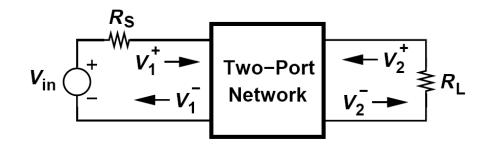
S-parameters

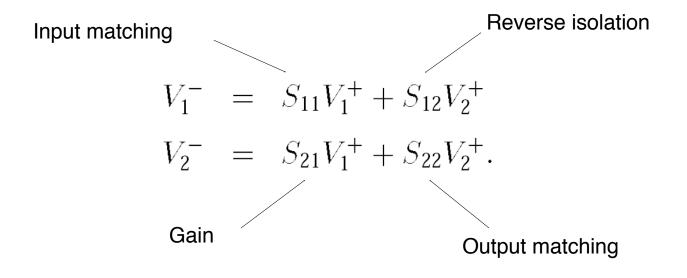
S₂₁ is the ratio of the wave incident on the load to that going to the input when the reflection from R_L is zero.
 Represents the gain.





s-parameters





complex = Re+Im or A+Ph, and frequency dependent



S and Z parameters

$$Z_{11} = \frac{((1+S_{11})(1-S_{22})+S_{12}S_{21})}{\Delta_S}Z_0$$
$$Z_{12} = \frac{2S_{12}}{\Delta_S}Z_0$$
$$Z_{21} = \frac{2S_{21}}{\Delta_S}Z_0$$
$$Z_{22} = \frac{((1-S_{11})(1+S_{22})+S_{12}S_{21})}{\Delta_S}Z_0$$

Where

$$\Delta_S = (1 - S_{11})(1 - S_{22}) - S_{12}S_{21}$$

The input impedance of a two-port network is given by:

$$Z_{in} = Z_{11} - \frac{Z_{12}Z_{21}}{Z_{22} + Z_L}$$

where Z_L is the impedance of the load connected to port two.



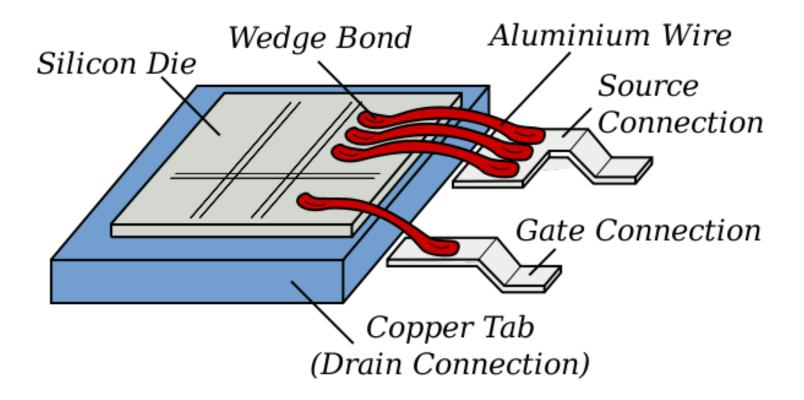
S-parameters

- S-parameters are typically measured using a <u>network analyzer</u>
- data is often displayed using <u>Smith-charts</u>



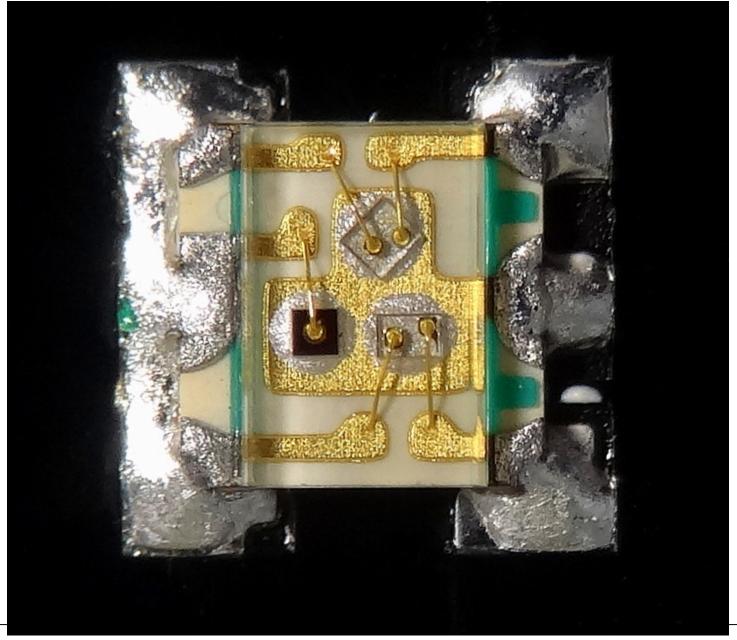


RF-IC packaging and measurements

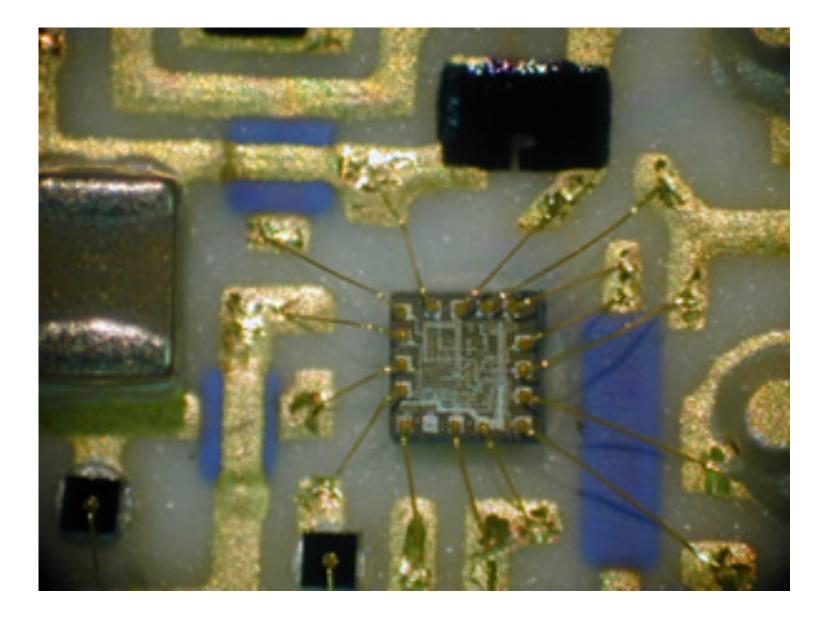


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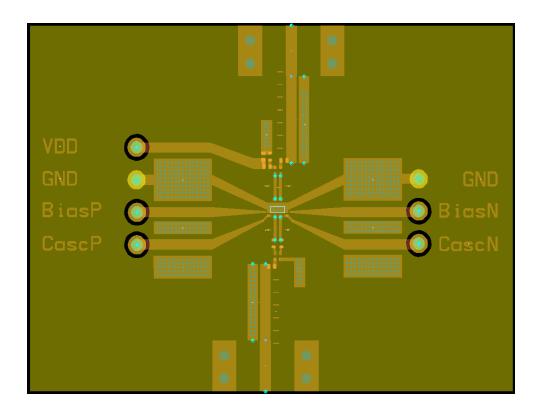


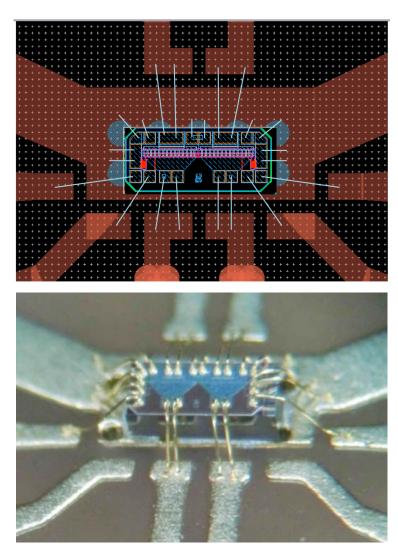






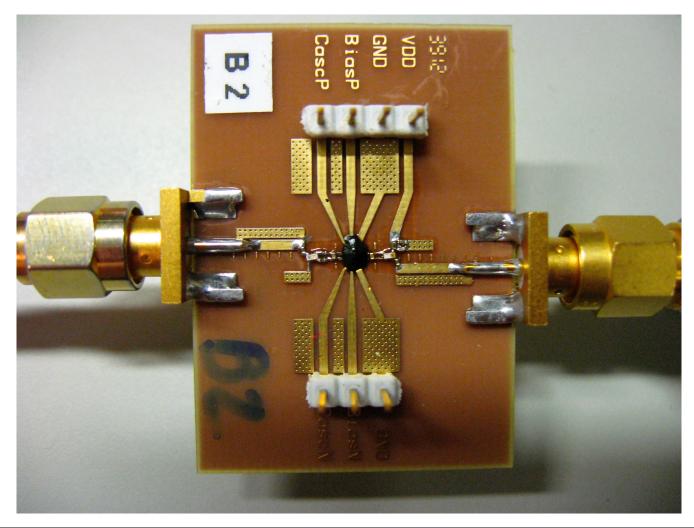
PCB and Bonding





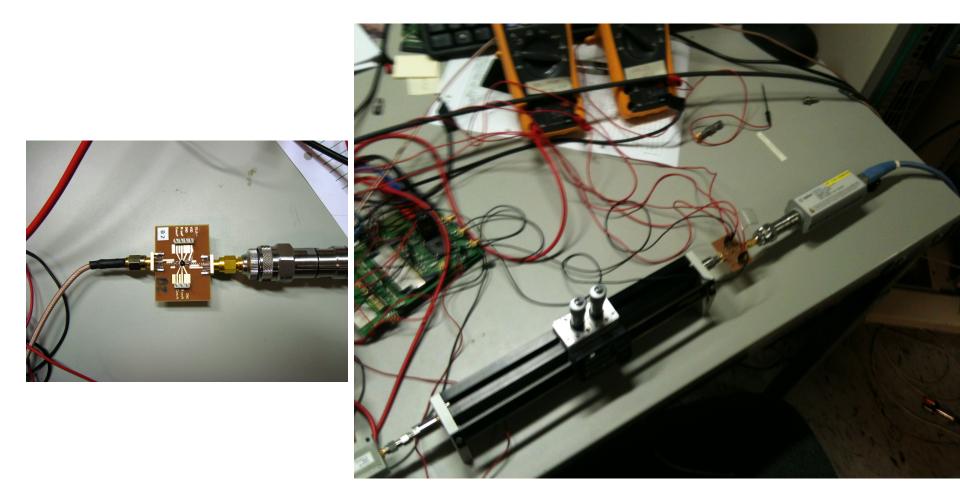


Mounted/soldered PCB

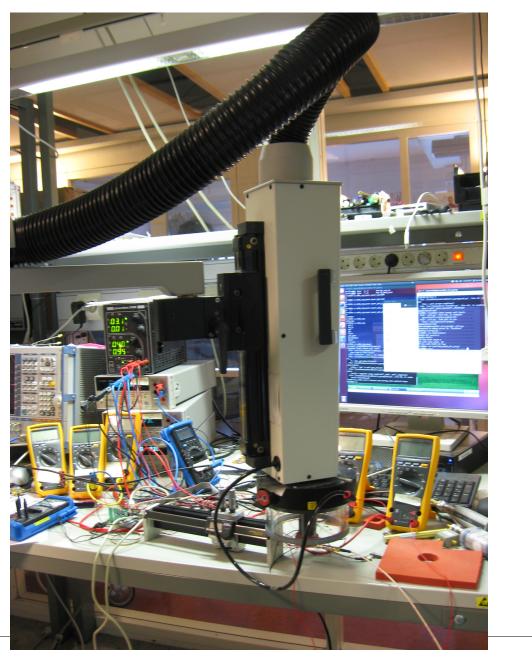




PCB measurements

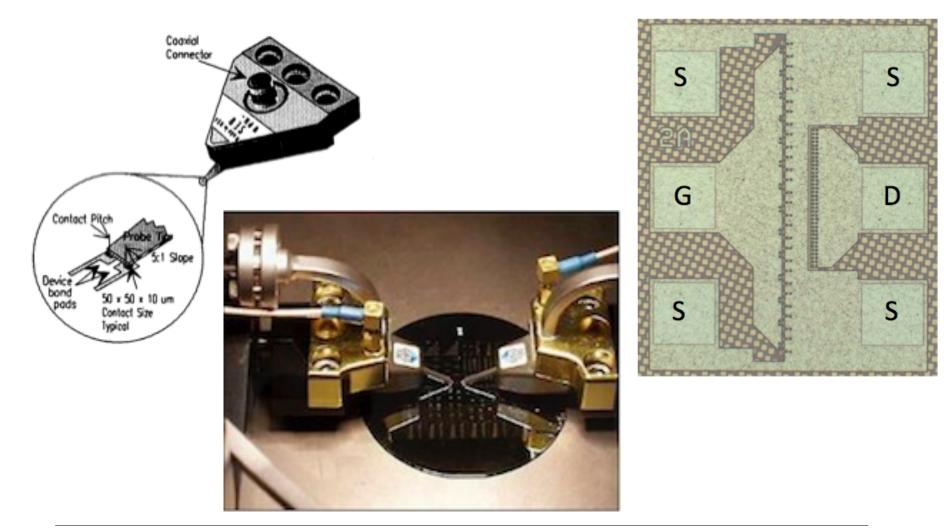








On-wafer measurements





Summary: S-parameters

- S-parameters are a powerful way to describe a linear electrical network at high frequency
- S-parameters change with frequency, load impedance, source impedance, network
- S_{11} is the reflection coefficient
- S₂₁ describes the forward transmission coefficient (corresponds to gain)
- S-parameters have both magnitude and phase information
- S-parameters may describe large and complex networks



Stability (no self-oscillations)

 Stability of an RF circuit can be checked by Stern (Rollett) stability factor which is based on S-parameters:

$$K = \frac{1 + |\Delta|^2 - |S_{11}|^2 - |S_{22}|^2}{2|S_{12}S_{21}|}$$

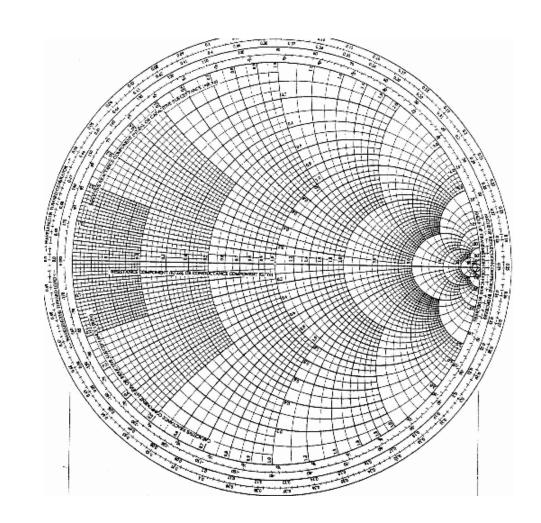
$$\Delta = |S_{11}S_{22} - S_{12}S_{21}|$$

• If K > 1 and $|\Delta| < 1$, then the circuit is unconditionally stable for any combination of input and output impedances.





Philip H Smith (1905 – 1987)



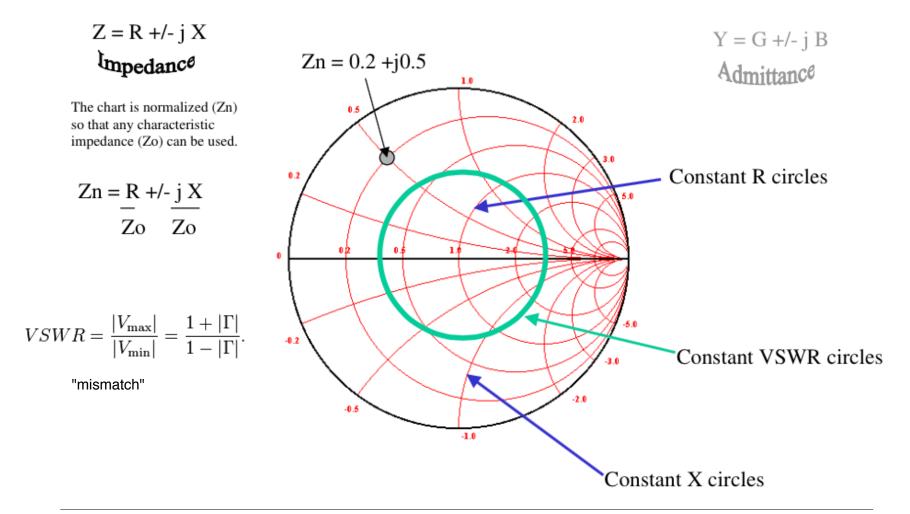


- The Smith chart is one of the most useful graphical tools for high frequency circuit applications.
- The goal of the Smith chart is to identify all possible impedances on the domain of existence of the reflection coefficient.

$$Z(d) = \frac{V(d)}{I(d)} = Z_0 \frac{1 + \Gamma(d)}{1 - \Gamma(d)} \qquad \Gamma = \frac{Z_L - 1}{Z_L + 1}$$

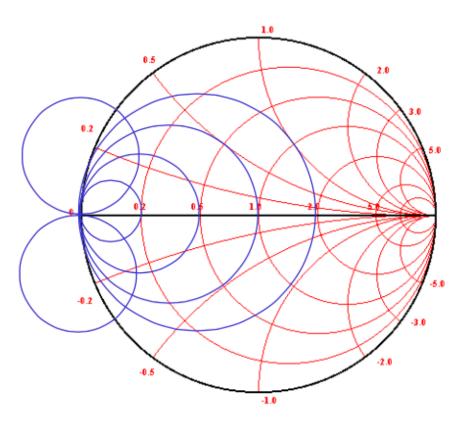
• "Normalized reflection coefficient": $Z(d) = Z_0 * z(d)$





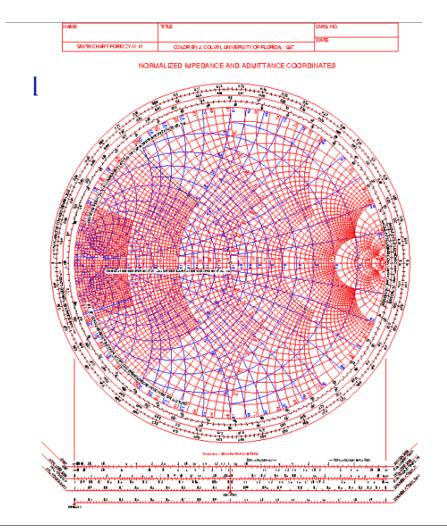


 There's also a mirror image of the chart that instead of having constant resistance circles, and constant reactance curves, has instead constant conductance circles and constant susceptance curves.





The full Smith chart





Smith Chart applications

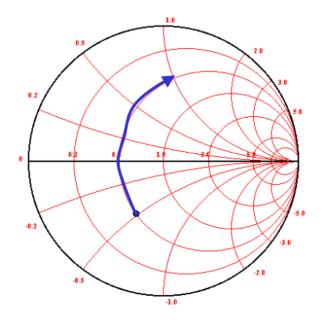
- Plotting/displaying impedances, e.g. as a function of frequency.
- Matching (impedance transformation)
- Determine VSWR
-



L in the Smith chart

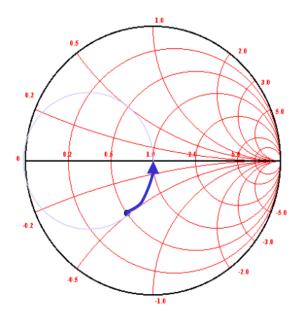
Series Inductors

Moves clockwise along circles of constant resistance



Shunt Inductors

Moves counter-clockwise along circles of constant conductance

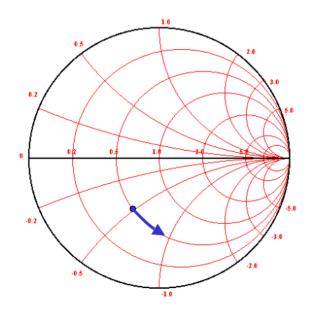




C in the Smith chart

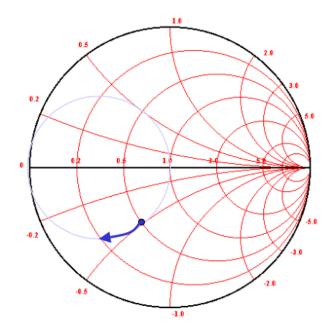
Series Capacitors

Moves counter-clockwise along circles of constant resistance



Shunt Capacitors

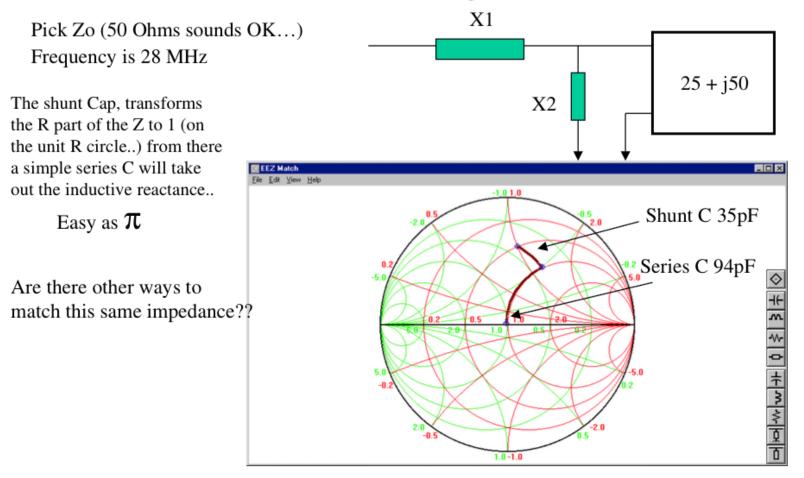
Moves clockwise along circles of constant conductance





Matching using Smith chart

Let's do some matching with L's and C's





Matching using Smith chart

